

Notice of References Cited	Application/Control No. 10/774,844		Applicant(s)/Patent Under Reexamination OZAWA, KIMIO	
	Examiner NATHAN M. CURS		Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0012509	01-2003	Chang et al.	385/50
	B	US-			
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FOREIGN PATENT DOCUMENTS

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